Search Notes				

Application/Control N	o. Applicant(s)/Patent under Reexamination		
10/791,223	EPSTEIN ET AL.	EPSTEIN ET AL.	
Examiner	Art Unit		
Brian S. Kwon	1614		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
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Continuity Data, Inventor Name search		
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